## EE 505

## Lecture 18

## Dynamic Current Source Matching Charge Redistribution DACs

## Review from Last Lecture

## Current Steering DAC



## Sub-radix Array



Termination resistor must be selected so that same attenuation is maintained Often only the first $\mathrm{n}_{1}$ MSB "slices" will be sub-radix

Effective number of bits when using sub-radix array will be less than $k$
Can be calibrated to obtain very low DNL (and maybe INL) with small area

## Review from Last Lecture

## Current Steering DAC



## Review from Last Lecture

## Current Steering DAC




## ${ }^{\text {Reviecuecurn }}$ furrent Steering DAC with Supply Independent Biasing



If transistors on top row are all matched, $\mathrm{I}_{\mathrm{X}}=\mathrm{V}_{\mathrm{REF}} / \mathrm{R}$
Thermometer coded structure (requires binary to thermometer decoder)

$$
\mathrm{I}_{\mathrm{A}}=\left(\frac{\mathrm{V}_{\mathrm{REF}}}{\mathrm{R}}\right) \sum_{\mathrm{i}=0}^{\mathrm{N}-1} \mathrm{~d}_{\mathrm{i}}
$$

Provides Differential Output Currents

# Current Current Steering DAC with Supply Independent Biasing 



If transistors on top row are binary weighted

$$
\mathrm{I}_{\mathrm{A}}=\left(\frac{\mathrm{V}_{\mathrm{REF}}}{\mathrm{R}}\right) \sum_{\mathrm{i}=0}^{\mathrm{n}-1} \frac{\mathrm{~d}_{\mathrm{i}}}{2^{\mathrm{n}-\mathrm{i}}}
$$

Provides Differential Output Currents

## Current Steering DAC with current output, buffered output, resistor load



## Matching is Critical in all DAC Considered



Obtaining adequate matching remains one of the major challenges facing the designer!

## Dynamic Current Source Matching



- Correct charge is stored on $C$ to make all currents equal to $I_{\text {REF }}$
- Does not require matching of transistors or capacitors
- Requires refreshing to keep charge on C
- Form of self-calibration
- Calibrates current sources one at a time
- Current source unavailable for use while calibrating
- Can be directly used in DACs (thermometer or binary coded)
- Still use steering rather than switching in DAC

Often termed "Current Copier" or "Current Replication" circuit

## Dynamic Current Source Matching



Extra current source can be added to facilitate background calibration

## Charge Redistribution Principle



$$
\sum_{i=1}^{k} C_{i}\left(V_{k}-V_{x}\right)=Q_{x}
$$

Charge on capacitors is preserved if there is no loss element on any of the capacitors

$$
\sum_{i=1}^{k} C_{i} V_{i}-V_{x} \sum_{i=1}^{k} C_{i}=Q_{x}
$$

Thus for any time-dependent voltages $\mathrm{V}_{1}, \ldots \mathrm{~V}_{\mathrm{k}}$

$$
V_{x}=\frac{\sum_{i=1}^{k} C_{i} V_{i}-Q_{X}}{\sum_{i=1}^{k} C_{i}}
$$

## Charge Redistribution Principle



$$
V_{x}=\frac{\sum_{i=1}^{k} C_{i} V_{i}-Q_{X}}{\sum_{i=1}^{k} C_{i}}
$$

All capacitors will have some gradual leakage thus causing $Q_{T}$ to change
How long will charge on a simple $\mathrm{M}-\mathrm{SiO}_{2}-\mathrm{M}$ capacitor be retained in a standard semiconductor process?


## DAC Architectures



During phase $\varphi_{1}, \mathrm{C}_{\mathrm{F}}$ is discharged and the remaining capacitors are charged to either $\mathrm{V}_{\text {REF }}$ or OV depending upon Boolean input total charge is denoted as $Q_{\text {SET }}$

During phase $\varphi_{2}$, all charge on input-connected capacitors is transferred to $\mathrm{C}_{\mathrm{F}}$

DAC output voltage is $V_{\text {out }}=\frac{Q_{S E T}}{C_{F}}$

## DAC Architectures



During phase $\varphi_{2}$, the previous output voltage is sampled on $C_{X}$

During phase $\varphi_{1}$, the Op Amp has feedback through $\mathrm{C}_{\mathrm{x}}$ thus establishing a null-port at the input so voltage on selected sampling capacitors is $\mathrm{V}_{\mathrm{REF}}$
$\mathrm{C}_{\mathrm{x}}$ does some good things
(mitigates $\mathrm{V}_{\mathrm{OS}}$, $1 / \mathrm{f}$ noise and finite gain errors)

## Consider basic charge redistribution circuit



Clocks are complimentary non-overlapping

## Basic charge redistribution circuit



During phase $\varphi_{1}$

$$
\begin{aligned}
& \mathrm{Q}_{\phi 1}=\mathrm{CV}_{\mathrm{IN}} \\
& \mathrm{Q}_{\mathrm{CF}}=0
\end{aligned}
$$

During phase $\varphi_{2}$

$$
\begin{aligned}
& \frac{\mathrm{Q}_{\phi 1}}{\mathrm{C}_{\mathrm{F}}}=\mathrm{V}_{\mathrm{OUT}} \\
& \frac{\mathrm{CV}_{\mathrm{IN}}}{\mathrm{C}_{\mathrm{F}}}=\mathrm{V}_{\mathrm{OUT}} \\
& \frac{\mathrm{~V}_{\mathrm{OUT}}}{\mathrm{~V}_{\mathrm{IN}}}=\frac{\mathrm{C}}{\mathrm{C}_{\mathrm{F}}}
\end{aligned}
$$

Serves as a noninverting amplifier
Gain can be very accurate
Output valid only during $\Phi_{2}$

## Another charge redistribution circuit



## Another charge redistribution circuit



During phase $\varphi_{1}$

$$
\begin{aligned}
& \mathrm{Q}_{\phi 1}=\mathrm{CV}_{\mathrm{IN}} \\
& \mathrm{Q}_{\mathrm{CF}}=0
\end{aligned}
$$

During phase $\varphi_{2}$

$$
\begin{aligned}
\frac{-\mathrm{Q}_{\phi 1}}{\mathrm{C}_{\mathrm{F}}} & =\mathrm{V}_{\mathrm{OUT}} \\
\frac{-\mathrm{CV}_{\mathrm{IN}}}{\mathrm{C}_{\mathrm{F}}} & =\mathrm{V}_{\mathrm{OUT}} \\
\frac{\mathrm{~V}_{\mathrm{OUT}}}{\mathrm{~V}_{\mathrm{IN}}} & =-\frac{\mathrm{C}}{\mathrm{C}_{\mathrm{F}}}
\end{aligned}
$$

Serves as a noninverting amplifier
Gain can be very accurate
Output valid only during $\Phi_{2}$

## Another charge redistribution circuit



## Another charge redistribution circuit



During phase $\varphi_{1}$

$$
\begin{aligned}
& \mathrm{Q}_{\phi 1}=0 \\
& \mathrm{Q}_{\mathrm{CF}}=0
\end{aligned}
$$

During phase $\varphi_{2}$

$$
\begin{aligned}
\mathrm{Q}_{\phi 2} & =\mathrm{CV}_{\mathrm{IN}} \\
\mathrm{Q}_{\mathrm{CF}} & =\mathrm{C}_{\mathrm{F}} \mathrm{~V}_{\mathrm{OUT}} \\
\mathrm{Q}_{\mathrm{CF}} & =-\mathrm{Q}_{\phi \phi}
\end{aligned}
$$

$$
\frac{\mathrm{v}_{\text {OUT }}}{v_{\text {IN }}}=-\frac{\mathrm{C}}{\mathrm{C}_{\mathrm{F}}}
$$

Serves as a inverting amplifier Gain can be very accurate Output valid only during $\Phi_{2}$

## Charge Redistribution DAC



During phase $\varphi_{1}$

$$
Q_{S E T}=V_{R E F} \sum_{i=0}^{n-1} d_{i} 2^{i} C
$$

During phase $\varphi_{2}$
Charge $\mathrm{Q}_{\text {SET }}$ is all transferred to $\mathrm{C}_{\mathrm{F}}$

$$
Q_{C F}=V_{\text {OUT }} 2^{n} C
$$

but

$$
Q_{S E T}=Q_{C F}
$$


$V_{\text {REF }} \sum_{i=0}^{n-1} d_{i} 2^{i} C=V_{\text {OUT }} 2^{n} C \longrightarrow V_{\text {OUT }}=V_{\text {REF }} \sum_{i=0}^{n-1} \frac{d_{i}}{2^{n-i}}$

## Another Redistribution DAC



During phase $\varphi_{1}$ selected switches set to $\mathrm{V}_{\text {REF }}$

$$
Q_{S E T}=V_{\text {REF }} \sum_{i=0}^{n} d_{i} C_{i}=V_{\text {REF }} \sum_{i=0}^{n} d_{i} \frac{C}{2^{n-i}}
$$

During phase $\varphi_{2}$ all switches connected to GND
Charge $\mathrm{Q}_{\text {SET }}$ is all redistributed among the capacitors

$$
\begin{gathered}
Q_{\text {SET }}=V_{\text {OUT }}\left(\sum_{i=1}^{n} C_{i}+C_{n}\right) \\
\text { but } \quad \sum_{i=1}^{n} C_{i}+C_{n}=\left(\sum_{i=1}^{n} \frac{C}{2^{i}}+C_{n}\right)=C \\
Q_{\text {SET }}=V_{\text {OUT }} C
\end{gathered}
$$



## Noise in DACs

Resistors and transistors contribute device noise but what about charge redistribution DACs?


## Noise in DACs

Resistors and transistors contribute device noise but what about charge redistribution DACs ?

## Noise in resistors:



Noise spectral density of $v_{\mathrm{n}}(\mathrm{t})$ at all frequencies $\quad S=4 k T R$
This is white noise!
k: Boltzmann's Constant
T: Temperature in Kelvin
$\mathrm{k}=1.38064852 \times 10^{-23} \mathrm{~m}^{2} \mathrm{~kg} \mathrm{~s}^{-2} \mathrm{~K}^{-1}$
At $300 \mathrm{~K}, \mathrm{kT}=4.14 \times 10^{-21}$

## Noise in DACs

Resistors and transistors contribute device noise but what about charge redistribution DACs ?

## Noise in linear circuits:



Due to any noise voltage source:

$$
\begin{gathered}
S_{v o r}=S_{v r}|T(j \omega)|^{2} \\
V_{v t_{t r e m}}=\sqrt{\int_{i=0}^{\infty} S_{v w n} \mathrm{df}}=\sqrt{\int_{f=0}^{\infty} S_{v .}|T(j \omega)|^{2} \mathrm{df}}
\end{gathered}
$$

Example: First-Order RC Network


$$
\mathrm{T}(s)=\frac{1}{1+\mathrm{RCs}}
$$

$$
\begin{array}{r}
S_{\text {voor }}=4 \mathrm{kTR}\left(\frac{1}{1+(\mathrm{RC} \omega)^{2}}\right) \\
V_{\text {mout }}=\sqrt{\int_{i=0}^{\infty} S_{\text {von }} \mathrm{df}}=\sqrt{\int_{f=0}^{\infty} \frac{4 \mathrm{kTR}}{1+\omega^{2} \mathrm{R}^{2} \mathrm{C}^{2}} \mathrm{df}}
\end{array}
$$

## Example: First-Order RC Network



$$
V_{w=}=\sqrt{\int_{i=0} S_{w e x} \mathrm{df}}=\sqrt{\int_{f=0}^{\infty} \frac{4 \mathrm{kTR}}{1+\omega^{2} \mathrm{R}^{2} \mathrm{C}^{2}} \mathrm{df}}
$$

From a standard change of variable with a trig identity, it follows that

$$
\boldsymbol{V}_{v a n}=\sqrt{\int_{i=0}^{\infty} S_{v a n} \text { df }}=\sqrt{\frac{\mathrm{KT}}{\mathrm{C}}}
$$

- The continuous-time noise voltage has an RMS value that is independent of $R$
- Noise contributed by the resistor is dependent only upon the capacitor value $C$
- This is often referred to at $\mathrm{kT} / \mathrm{C}$ noise and it can be decreased at a given T only by increasing C


## "kT/C" Noise at T=300K


"kT/C" Noise at T=300K


Example: Switched Capacitor Sampler



Track mode


Hold mode

Example: Switched Capacitor Sampler



Track mode


Hold mode

## Example: Switched Capacitor Sampler

T is the period of the sampler


$\boldsymbol{v}_{\mathrm{n}}(\mathrm{mT})$ is a discrete-time sequence obtained by sampling continuous-time noise waveform

Characterization of a noise sequence


Theorem If $\boldsymbol{v}(\mathrm{t})$ is a continuous-time zero-mean noise source and $\langle\boldsymbol{V}(\mathrm{kT})\rangle$ is a sampled version of $\mathcal{V}(\mathrm{t})$ sampled at times $\mathrm{T}, 2 \mathrm{~T}, \ldots$. then the RMS value of the continuous-time waveform is the same as that of the sampled version of the waveform. This can be expressed as $\boldsymbol{V}_{\text {ews }}=\hat{V}_{\text {vus }}$

Theorem
If $v(\mathrm{t})$ is a continuous-time zero-mean noise signal and $<\boldsymbol{V}(\mathrm{kT})>$ is a sampled version of $\boldsymbol{v}(\mathrm{t})$ sampled at times $\mathrm{T}, 2 \mathrm{~T}, \ldots$. then the standard deviation of the random variable $\mathcal{V}(\mathrm{kT})$, denoted as $\sigma_{i}$
satisfies the expression $\sigma_{V}=V_{\text {pus }}=\hat{V_{\text {RII }}}$

Example: Switched Capacitor Sampler

$v_{\text {vem }}=\sqrt{\frac{k T}{C}}$
k: Boltzmann's constant T: temperature in Kelvin

## End of Lecture 18

